

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY

V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)
30	0.27 at V _{GS} = 10 V	410	280 nC
	0.39 at V _{GS} = 4.5 V		

FEATURES

- DT-Trench Power MOSFET
- Very low on-resistance
- Excellent gate charge x R_{DS(on)} product(FOM)

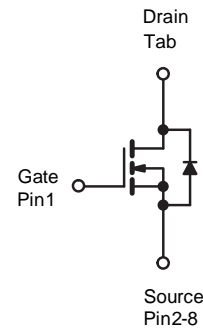
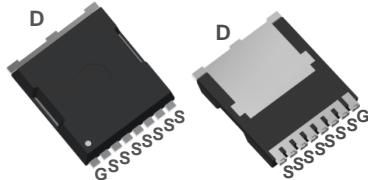


RoHS
COMPLIANT

APPLICATIONS

- DC-DC Converter
- Ideal for high-frequency switching and synchronous rectification

TOLL Pin Configuration



ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current (T _J = 150 °C) ^a	I _D	T _C = 25 °C	A
		T _C = 100 °C	
Pulsed Drain Current ^b	I _{DM}	1640	
Single Avalanche Energy	E _{AS}	1439	mJ
Maximum Power Dissipation ^c	P _D	T _C = 25 °C	W
		T _C = 100 °C	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature)		260	

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	MAX	UNIT
Junction-to-Ambient (PCB Mount) ^d	R _{thJA}	55	°C/W
Junction-to-Case (Drain)	R _{thJC}	0.6	

Notes

- Calculated continuous current based on maximum allowable junction temperature.
- Repetitive rating; pulse width limited by max. junction temperature.
- P_d is based on max. junction temperature, using junction-case thermal resistance.
- The value of R_{thJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25 °C.

SPECIFICATIONS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	1.0	-	2.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	μA
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$	-	-	100	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \geq 10\text{ V}, V_{GS} = 10\text{ V}$	410	-	-	A
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$	-	0.27	0.35	m Ω
		$V_{GS} = 4.5\text{ V}, I_D = 30\text{ A}$	-	0.39	0.50	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 5\text{ V}, I_D = 30\text{ A}$	-	230	-	S
Dynamic ^b						
Input Capacitance	C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 15\text{ V}, f = 0.1\text{ MHz}$	-	22300	-	μF
Output Capacitance	C_{oss}		-	12530	-	
Reverse Transfer Capacitance	C_{rss}		-	168	-	
Total Gate Charge ^c	Q_g	$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 30\text{ A}$	-	280	-	nC
Gate-Source Charge ^c	Q_{gs}		-	72	-	
Gate-Drain Charge ^c	Q_{gd}		-	18	-	
Gate Resistance	R_g	$f = 1\text{ MHz}$	-	1.9	-	Ω
Turn-On Delay Time ^c	$t_{d(on)}$	$V_{DD} = 15\text{ V}, I_D = 30\text{ A}, R_g = 1.6\text{ }\Omega$ $V_{GS} = 10\text{ V}$	-	30	-	ns
Rise Time ^c	t_r		-	36	-	
Turn-Off Delay Time ^c	$t_{d(off)}$		-	169	-	
Fall Time ^c	t_f		-	70	-	
Drain-Source Body Diode Ratings and Characteristics ^b ($T_C = 25\text{ }^\circ\text{C}$)						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	-	-	410	A
Pulsed Current	I_{SM}		-	-	1640	A
Forward Voltage ^a	V_{SD}	$I_F = 30\text{ A}, V_{GS} = 0\text{ V}$	-	-	1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 30\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$	-	25	-	ns
Reverse Recovery Charge	Q_{rr}		-	170	-	nC

Notes

- Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
- Guaranteed by design, not subject to production testing.
- Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig 1: Output Characteristics

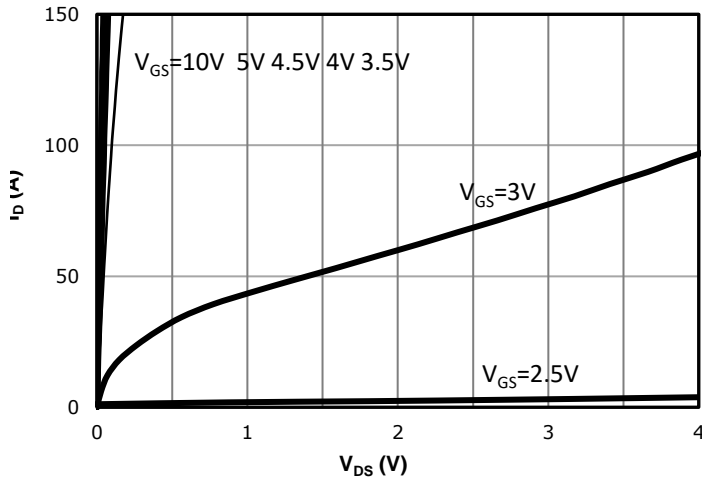


Fig 2: Transfer Characteristics

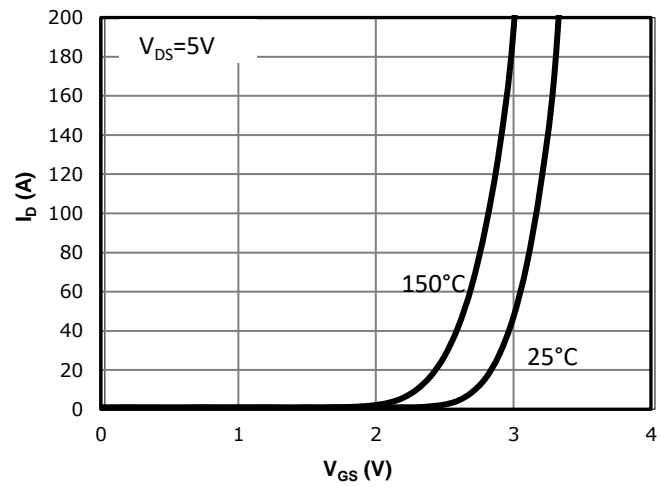


Fig 3: $R_{DS(on)}$ vs Drain Current and Gate Voltage

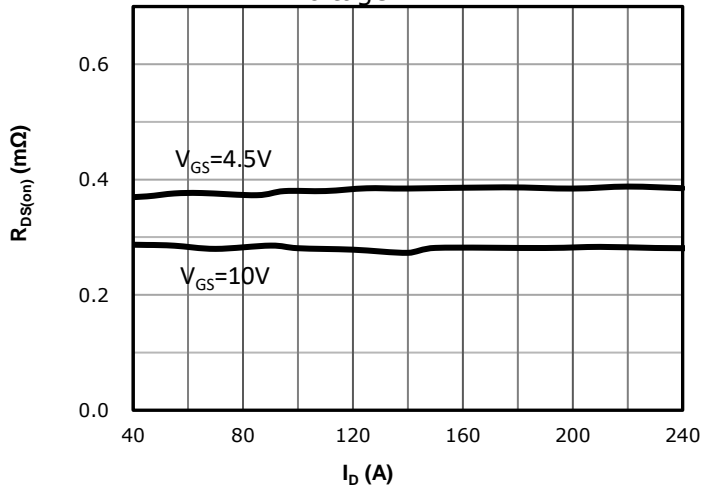


Fig 4: $R_{DS(on)}$ vs Gate Voltage

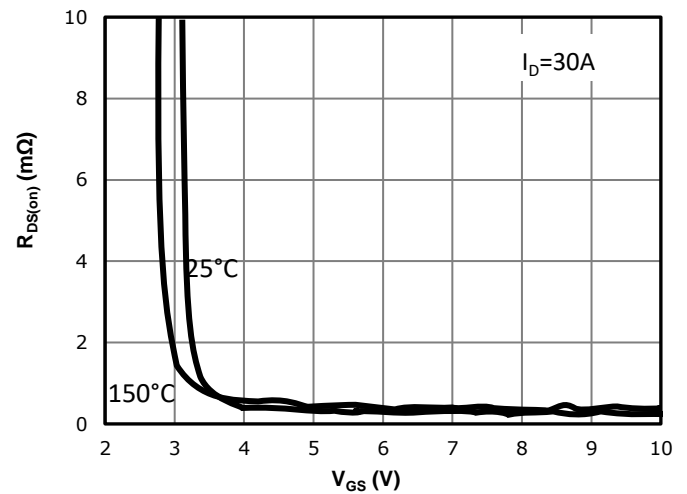


Fig 5: $R_{DS(on)}$ vs. Temperature

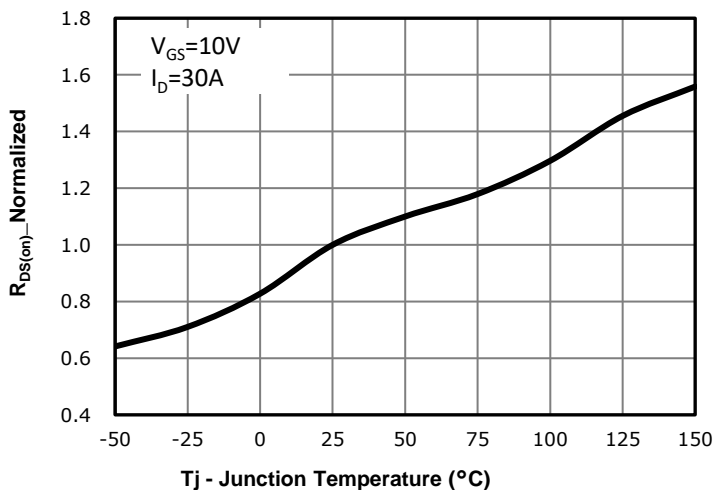
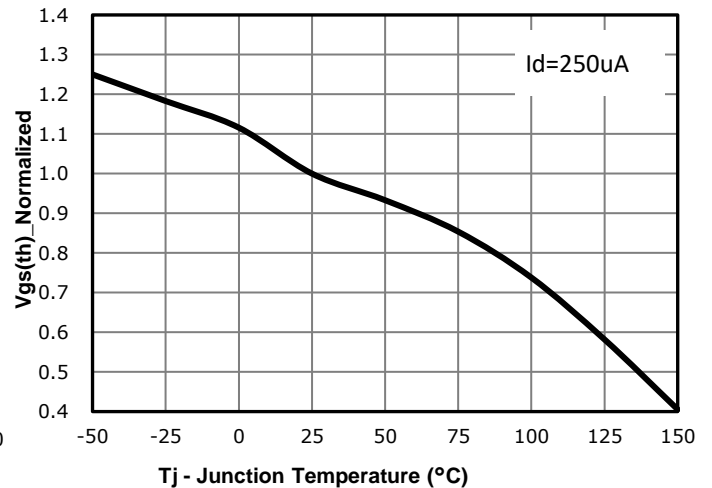


Fig 6: $V_{GS(th)}$ vs. Temperature



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig 7: BV_{dss} vs. Temperature

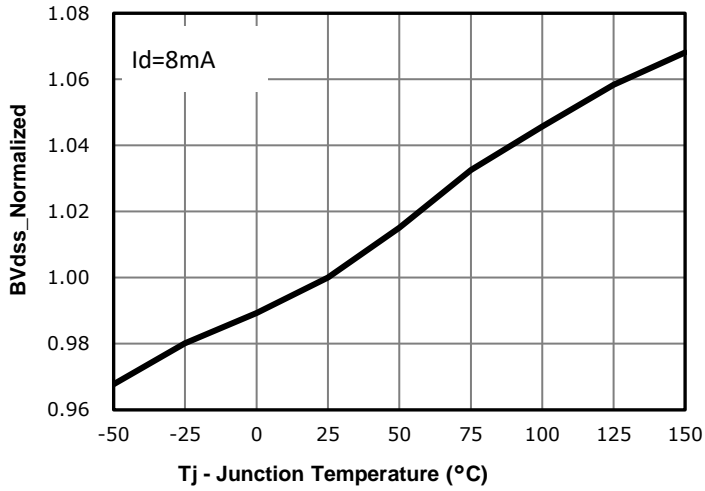


Fig 8: Capacitance Characteristics

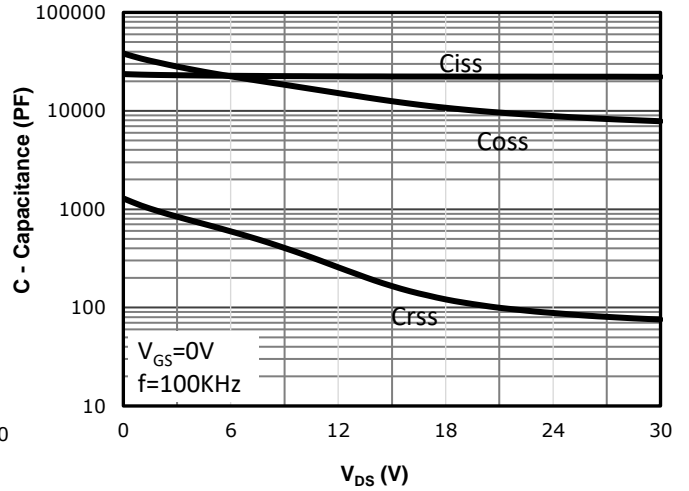


Fig 9: Gate Charge Characteristics

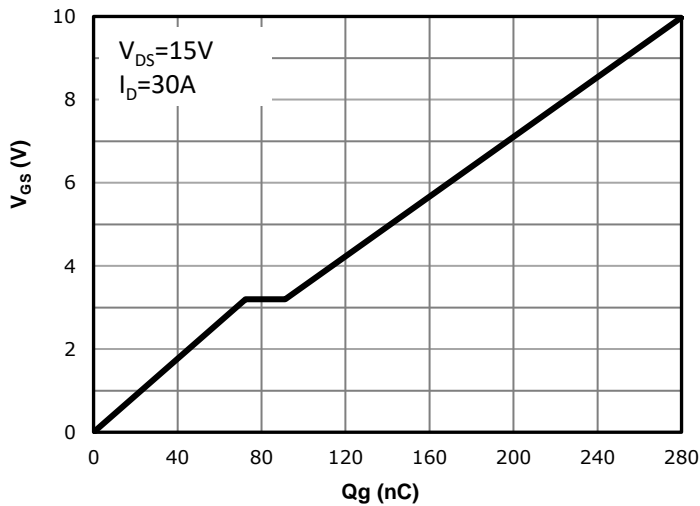


Fig 10: Body-diode Forward Characteristics

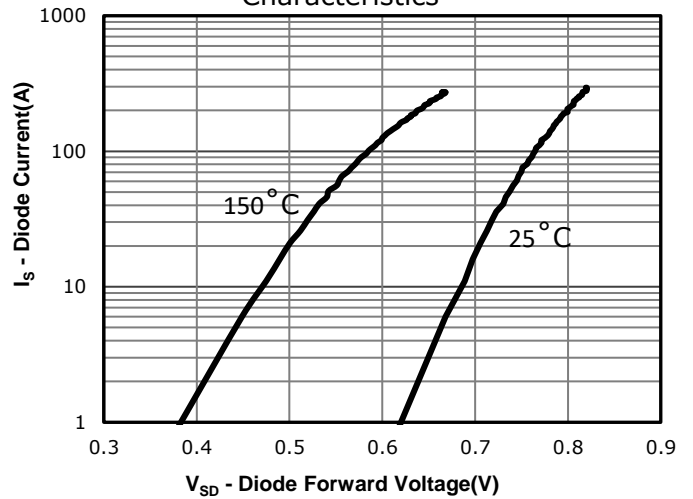


Fig 11: Power Dissipation

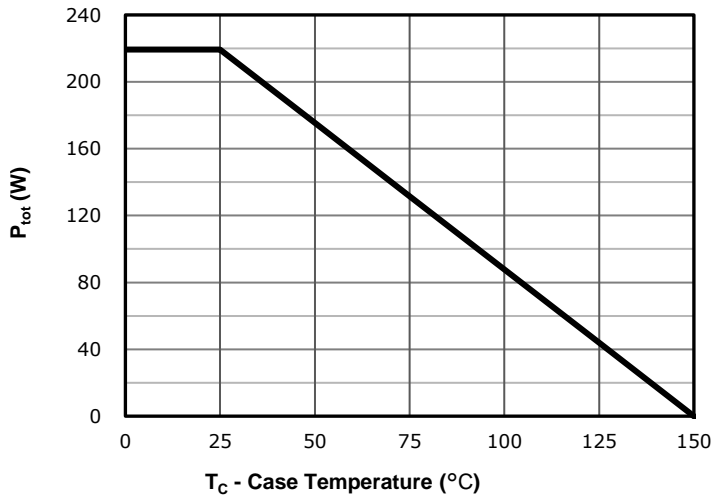
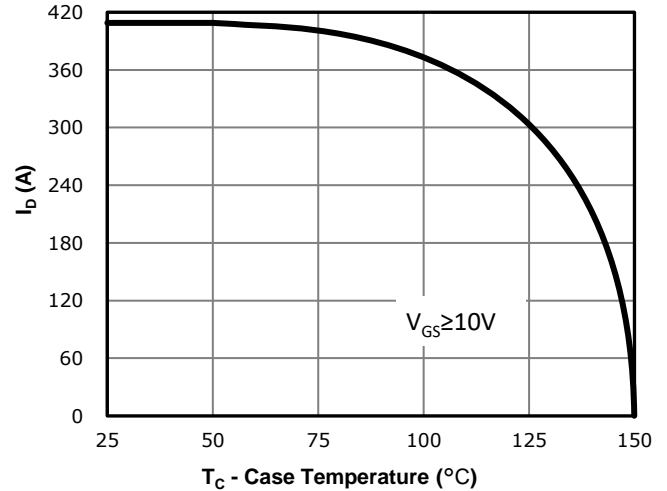


Fig 12: Drain Current Derating



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig 13: Safe Operating Area

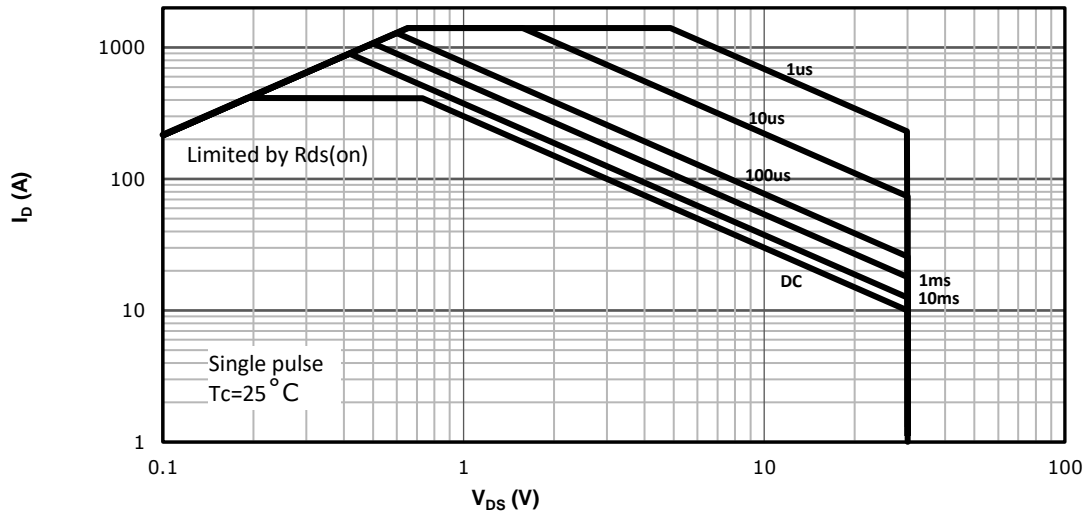
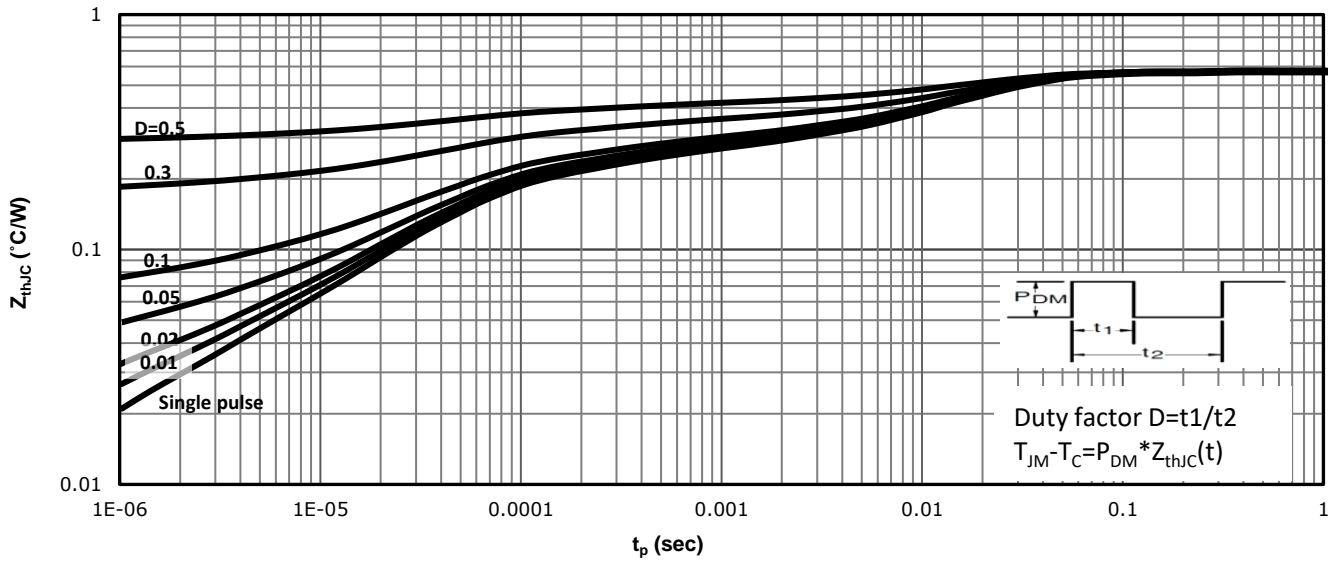
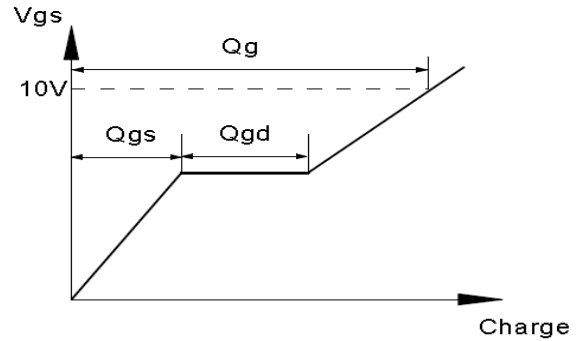
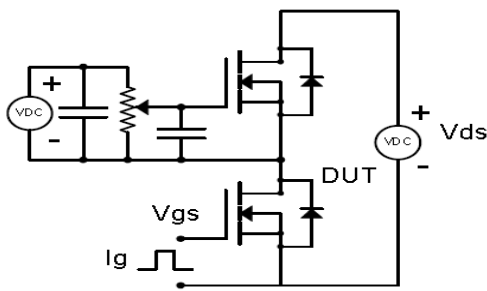


Fig 14: Max. Transient Thermal Impedance

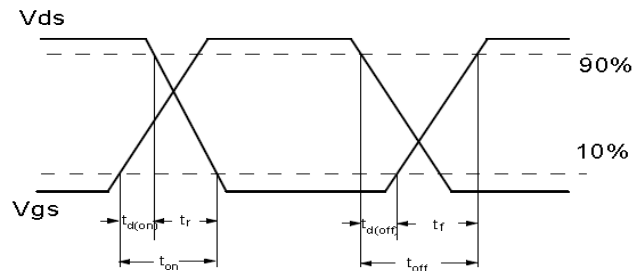
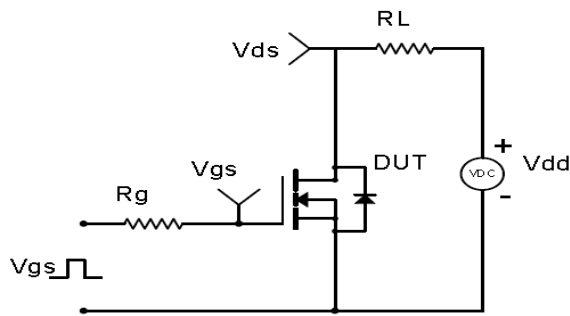


Test Circuit & Waveform

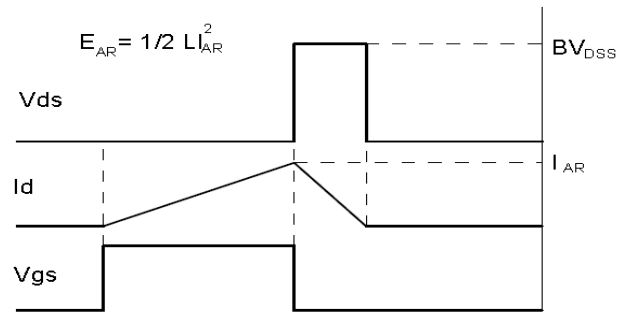
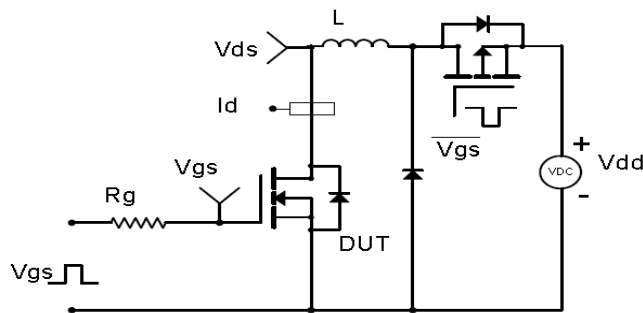
Gate Charge Test Circuit & Waveform



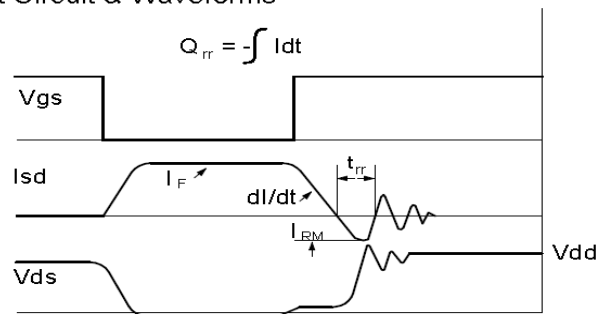
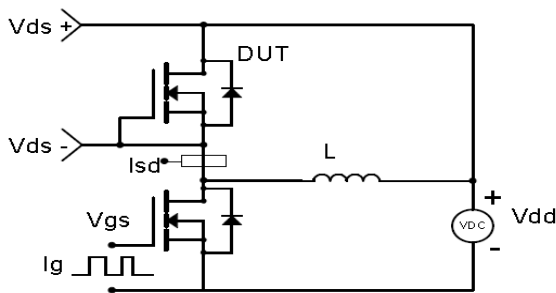
Resistive Switching Test Circuit & Waveforms



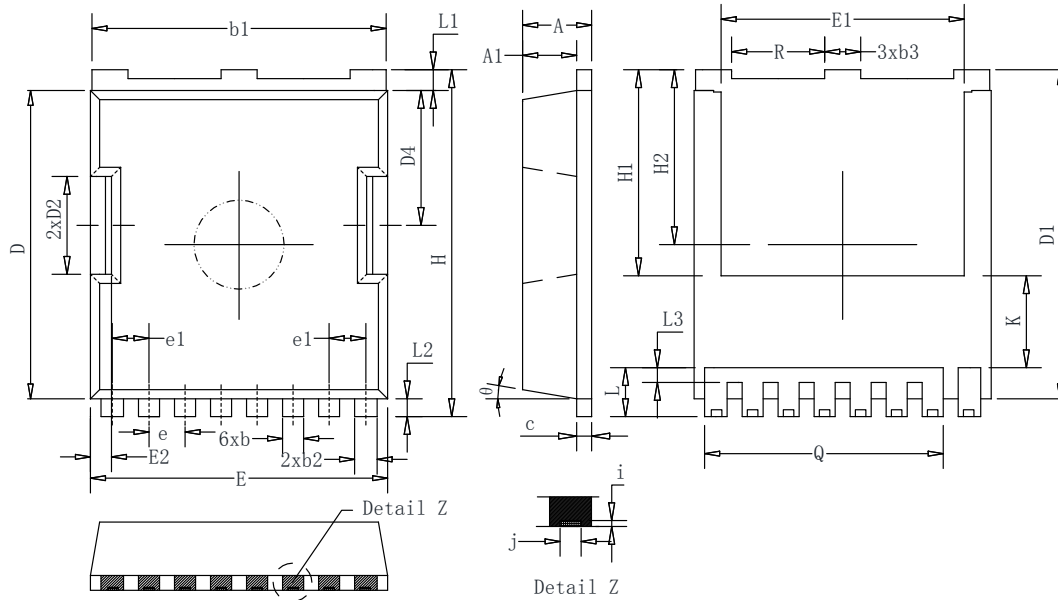
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



TOLL PACKAGE OUTLINE



COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	2.05	2.30	2.65	E2	0.40	0.70	0.90
A1	1.50	1.80	2.10	H	11.30	11.70	12.10
b	0.50	0.70	0.90	H1	6.95 BSC		
b_1	9.50	9.80	10.05	H2	5.90 BSC		
b_2	0.50	0.75	1.00	i	0.10 REF		
b_3	1.00	1.20	1.45	j	0.35 REF		
c	0.30	0.50	0.75	K	3.10 REF		
D	10.10	10.40	10.70	L	1.45	1.65	1.85
D1	10.80	11.10	11.40	L1	0.50	0.70	0.90
D2	3.10	3.30	3.50	L2	0.40	0.60	0.80
D4	4.35	4.55	4.80	L3	0.30	0.50	0.70
e	1.20 BSC			Q	7.95 REF		
e_1	1.225 BSC			R	2.80	3.10	3.35
E	9.65	9.90	10.15	θ	10°REF		
E1	7.80	8.10	8.50				

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